	CHAU NGUYEN	2176		
Notice of Notes affects of the	Examiner	Art Unit	Page 1 of 1	
Notice of References Cited	10/810,964	Reexamination DEY ET AL.		
	Application/Control No.	Applicant(s)/Patent Under		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2001/0053190	12-2001	Srinivasan, Venugopal	375/340
	В	US-			
	U	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Ι	US-			
	-	US-			
	J	US-			
	К	US-			
	┙	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
	C		
	V		
	w		
	х		

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